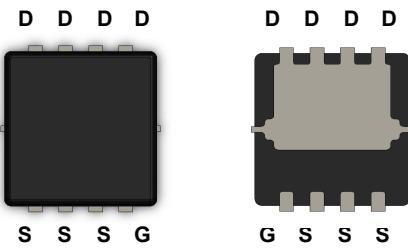


## General Description

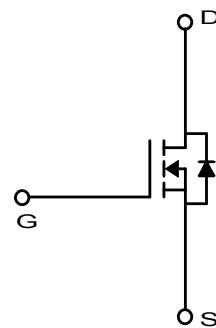
The MDV1523 uses advanced MagnaChip's MOSFET Technology, which provides high performance in on-state resistance, fast switching performance and excellent quality. MDV1523 is suitable for DC/DC converter and general purpose applications.

## Features

- $V_{DS} = 30V$
- $I_D = 24A @ V_{GS} = 10V$
- $R_{DS(ON)}$   
 $< 6.1m\Omega @ V_{GS} = 10V$   
 $< 8.4m\Omega @ V_{GS} = 4.5V$
- 100% UIL Tested
- 100%  $R_g$  Tested



PDFN33



## Absolute Maximum Ratings ( $T_a = 25^\circ C$ )

Characteristics		Symbol	Rating	Unit
Drain-Source Voltage		$V_{DSS}$	30	V
Gate-Source Voltage		$V_{GSS}$	$\pm 20$	V
Continuous Drain Current <sup>(1)</sup>	$T_c=25^\circ C$ (Silicon limited)	$I_D$	50.3	A
	$T_c=25^\circ C$ (Package limited)		24	
	$T_c=70^\circ C$		24	
	$T_a=25^\circ C$		17.8 <sup>(3)</sup>	
	$T_a=70^\circ C$		14.3 <sup>(3)</sup>	
Pulsed Drain Current		$I_{DM}$	60	A
Power Dissipation	$T_c=25^\circ C$	$P_D$	27.1	W
	$T_c=70^\circ C$		17.3	
	$T_a=25^\circ C$		3.4 <sup>(3)</sup>	
	$T_a=70^\circ C$		2.2 <sup>(3)</sup>	
Single Pulse Avalanche Energy <sup>(2)</sup>		$E_{AS}$	112	mJ
Junction and Storage Temperature Range		$T_J, T_{stg}$	-55~150	°C

## Thermal Characteristics

Characteristics		Symbol	Rating	Unit
Thermal Resistance, Junction-to-Ambient <sup>(1)</sup>	$R_{\theta JA}$		36	°C/W
Thermal Resistance, Junction-to-Case				

## Ordering Information

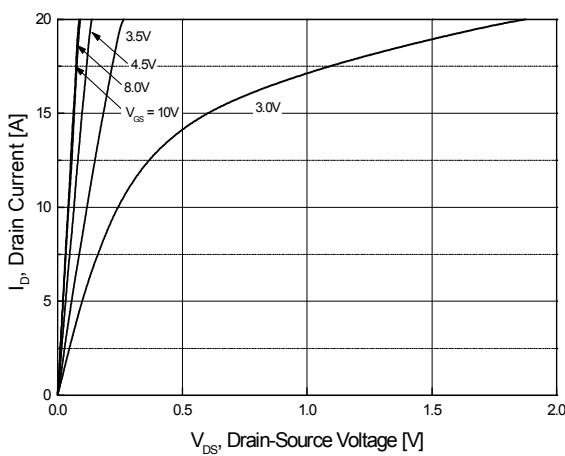
Part Number	Temp. Range	Package	Packing	Quantity	Rohs Status
MDV1523URH	-55~150°C	PowerDFN33	Tape & Reel	5000 units	Halogen Free

## Electrical Characteristics ( $T_J = 25^\circ\text{C}$ )

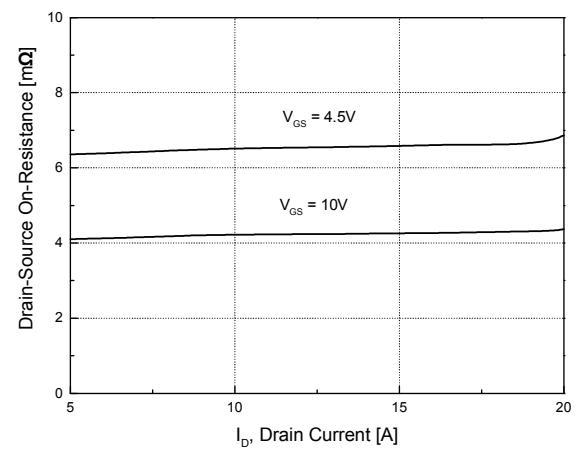
Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	30	-	-	V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.3	1.8	2.7	
Drain Cut-Off Current	$I_{DS}$	$V_{DS} = 30\text{V}, V_{GS} = 0\text{V}$ $T_J = 55^\circ\text{C}$	-	-	1	$\mu\text{A}$
Gate Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$	-	-	$\pm 0.1$	
Drain-Source ON Resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{V}, I_D = 14\text{A}$ $T_J = 125^\circ\text{C}$	-	5.3	6.1	$\text{m}\Omega$
		$V_{GS} = 4.5\text{V}, I_D = 12\text{A}$	-	7.7	8.8	
Forward Transconductance	$g_{fs}$	$V_{DS} = 5\text{V}, I_D = 14\text{A}$	-	7.0	8.4	
			-	28.1	-	S
<b>Dynamic Characteristics</b>						
Total Gate Charge	$Q_{g(10\text{V})}$	$V_{DS} = 15.0\text{V}, I_D = 14\text{A}, V_{GS} = 10\text{V}$	17.9	25.5	33.2	nC
Total Gate Charge	$Q_{g(4.5\text{V})}$		8.4	12.1	15.7	
Gate-Source Charge	$Q_{gs}$		-	4.7	-	
Gate-Drain Charge	$Q_{gd}$		-	3.6	-	
Input Capacitance	$C_{iss}$	$V_{DS} = 15.0\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$	1109	1584	2059	pF
Reverse Transfer Capacitance	$C_{rss}$		110	157	204	
Output Capacitance	$C_{oss}$		219	312	406	
Turn-On Delay Time	$t_{d(on)}$	$V_{GS} = 10\text{V}, V_{DS} = 15.0\text{V}, I_D = 14\text{A}, R_G = 3.0\Omega$	-	8.8	-	ns
Rise Time	$t_r$		-	11.9	-	
Turn-Off Delay Time	$t_{d(off)}$		-	35.8	-	
Fall Time	$t_f$		-	9.8	-	
Gate Resistance	$R_g$	$f=1\text{ MHz}$	0.5	1.3	3.0	$\Omega$
<b>Drain-Source Body Diode Characteristics</b>						
Source-Drain Diode Forward Voltage	$V_{SD}$	$I_S = 14\text{A}, V_{GS} = 0\text{V}$	-	0.81	1.1	V
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 14\text{A}, dI/dt = 100\text{A}/\mu\text{s}$	-	27.3	41.0	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	18.1	27.1	nC

Note :

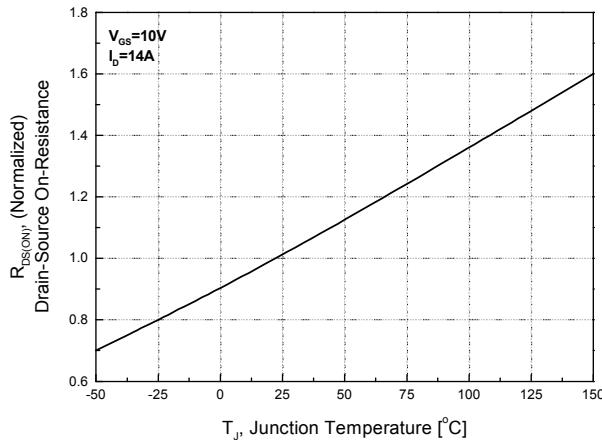
1. Surface mounted FR-4 board by JEDEC (jesd51-7)
2.  $E_{AS}$  is tested at starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.1\text{mH}$ ,  $I_{AS} = 26\text{A}$ ,  $V_{DD} = 27\text{V}$ ,  $V_{GS} = 10\text{V}$
3.  $T < 10\text{sec}$



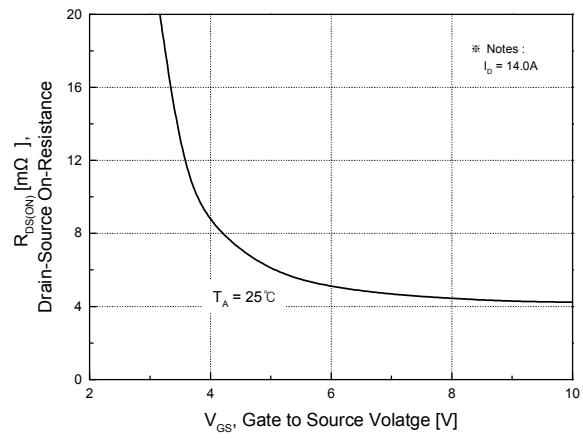
**Fig.1 On-Region Characteristics**



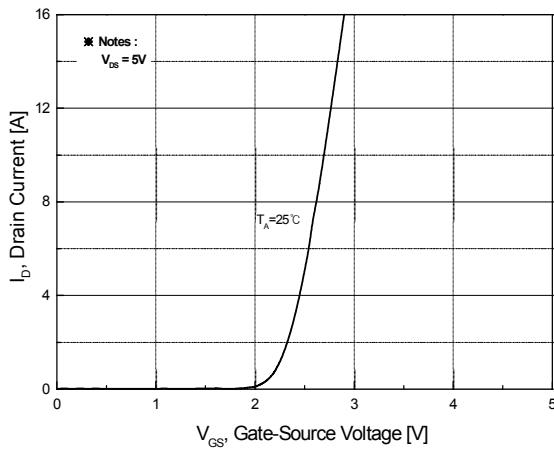
**Fig.2 On-Resistance Variation with Drain Current and Gate Voltage**



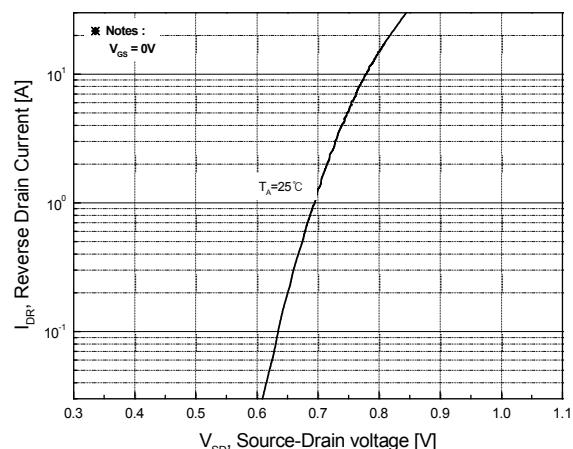
**Fig.3 On-Resistance Variation with Temperature**



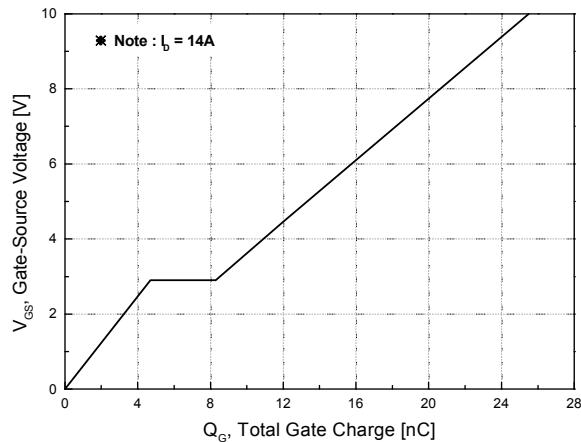
**Fig.4 On-Resistance Variation with Gate to Source Voltage**



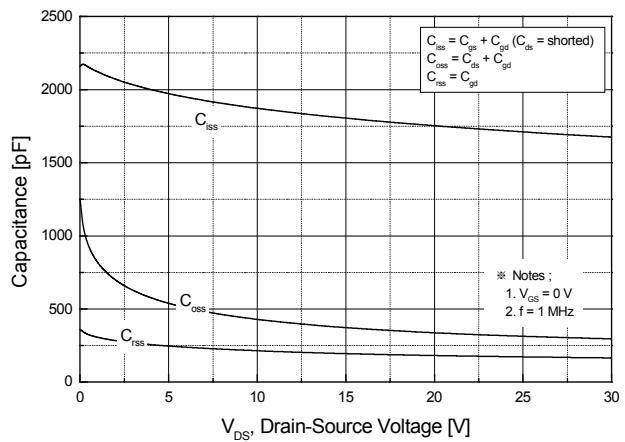
**Fig.5 Transfer Characteristics**



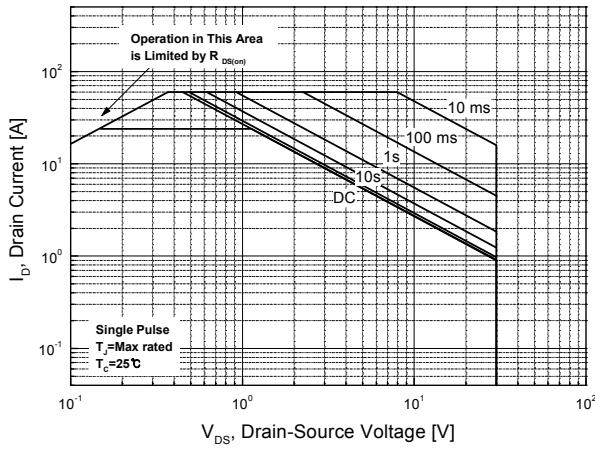
**Fig.6 Body Diode Forward Voltage Variation with Source Current and Temperature**



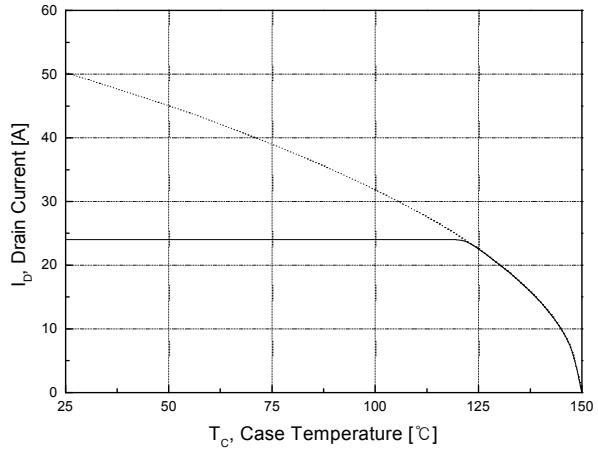
**Fig.7 Gate Charge Characteristics**



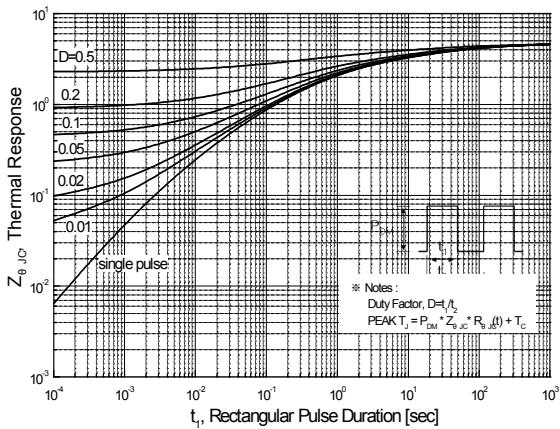
**Fig.8 Capacitance Characteristics**



**Fig.9 Maximum Safe Operating Area**



**Fig.10 Maximum Drain Current vs. Case Temperature**

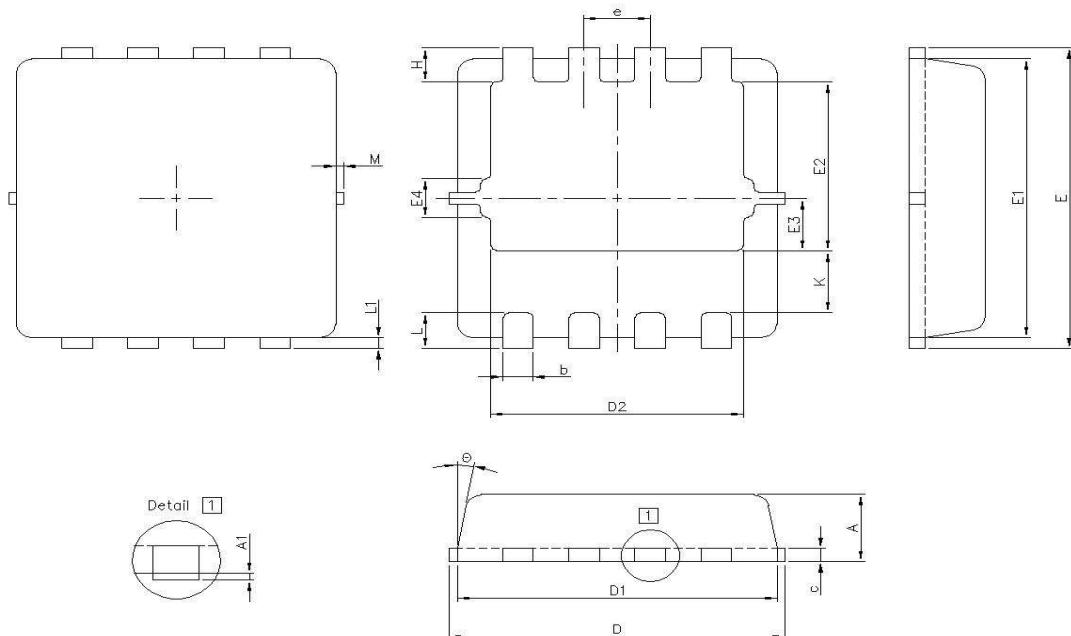


**Fig.11 Transient Thermal Response Curve**

## Package Dimension

### PowerDFN33 (3.3x3.3mm)

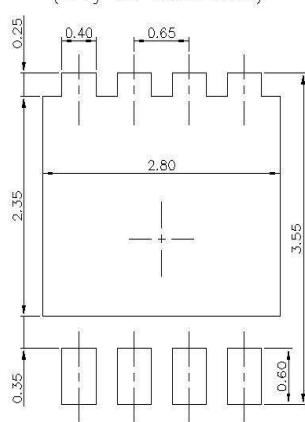
Dimensions are in millimeters, unless otherwise specified



(Unit: mm)

DIM	Min	Max	DIM	Min	Max
A	0.70	0.80	E2	1.78	1.98
A1	0.00	0.05	E3	0.49	0.69
b	0.25	0.35	E4	0.35	TYP.
c	0.10	0.25	e	0.65	BSC
D	3.20	3.40	K	0.70	TYP.
D1	3.00	3.20	L	0.30	0.50
D2	2.39	2.59	L1	0.13	TYP.
E	3.25	3.45	H	0.27	0.47
E1	3.00	3.20	Θ	0	12

Land Pattern  
(Only for Reference)



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